(36) GSM Band Balun with Coupler (SCI-901 W/F)

FEATURES

- Passive integration on silicon substrate
- Low insertion loss in pass band
- Small size: 1.6 mm x 1.2 mm (wirebond)
  2.0 mm x 1.2 mm (flip chip)
- Pb-free solder bump
- Low profile: 0.25 mm height (wirebond)
  0.40 mm height (flip chip)
- Directly attachable on PCB or flipped on PCB
- Operating temperature: -40°C to +85°C
- Storage temperature: -40°C to +85°C

DESCRIPTION

STATS ChipPAC’s SCI-901W/F is a balun with coupler for GSM band applications. The IPD has low passband insertion loss and small size. It is composed of thick copper inductors and Metal-Insulator-Metal capacitors which are fabricated on a silicon substrate using our IPD (Integrated Passive Device) process. The pad or bump size and pitch of the IPD are selected so that the device can be mounted directly on a PCB or laminate substrate using conventional wirebonding or surface mount techniques. The low profile and small form-factor of the device make it especially suitable for SiP applications.

ELECTRICAL SPECIFICATIONS

(Test board loss 0.04 dB included)

<table>
<thead>
<tr>
<th>Specification</th>
<th>Unit</th>
<th>Min.</th>
<th>Typical</th>
<th>Max.</th>
</tr>
</thead>
<tbody>
<tr>
<td>Pass Band</td>
<td>MHz</td>
<td>824</td>
<td>915</td>
<td></td>
</tr>
<tr>
<td>Insertion Loss</td>
<td>dB</td>
<td>1.1</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Return Loss</td>
<td>dB</td>
<td>15</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Differential Impedance</td>
<td>Ohm</td>
<td></td>
<td>100</td>
<td></td>
</tr>
<tr>
<td>Amplitude Imbalance</td>
<td>dB</td>
<td></td>
<td>0.3</td>
<td></td>
</tr>
<tr>
<td>Phase Imbalance</td>
<td>deg</td>
<td></td>
<td>6.0</td>
<td></td>
</tr>
<tr>
<td>Coupling Coefficient</td>
<td>dB</td>
<td></td>
<td>-20</td>
<td></td>
</tr>
<tr>
<td>Directivity</td>
<td>dB</td>
<td>20</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Size</td>
<td>mm</td>
<td>1.6 x 1.2 (WB)</td>
<td>2.0 x 1.2 (FC)</td>
<td></td>
</tr>
</tbody>
</table>

DIMENSIONS

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TYPICAL CHARACTERISTICS

- Insertion Loss (dB)
- Return Loss (dB)
- Phase Imbalance (dB)
- Amplitude Imbalance (dB)
- Return Loss (dB)
- Directivity (dB)
- Coupling Coefficient (dB)

TEST BOARD DRAWING

**SCI-901W (Wirebond)**  **SCI-901F (Flip Chip)**

NOTES

All dimension measurement units are in millimeters (mm). Electrical performance and typical values are measured at room temperature. For best results, ground plane directly beneath the device should be in the top metal layer.

Refer to “Appendix A” for:
- Pad sizes and typical wirebond length used in the wirebonded IPD products.
- Recommended solder thermal profile, landing pattern recommendation and bump specifications used in the flip chip IPD products.